## Application/Control No. Applicant(s)/Patent Under Reexamination 10/657,181 CHIU ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 An T. Luu 2816 **U.S. PATENT DOCUMENTS** Document Number Date Classification Name Country Code-Number-Kind Code MM-YYYY US-6,703,803 03-2004 Ohiwa et al. 318/138 Α В US-6,650,074 11-2003 Vyssotski et al. 318/254 С US-5,952,798 09-1999 Jones et al. 318/268 US-D US-Ε US-F US-G US-Н US-US-J US-Κ US-US-М FOREIGN PATENT DOCUMENTS **Document Number** Date Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν 0 Р Q R S T **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U W

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